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Jameco Part Number 27764

256-bit TTL bipolar PROM (32 x 8) 82S23/82S123

DESCRIPTION

The 82S23 and 82S123 are field programmable, which means that custom patterns are immediately available by following the Signetics Generic I fusing procedure. The 82S23 and 82S123 devices are supplied with all outputs at logical Low. Outputs are programmed to a logic High level at any specified address by fusing the Ni-Cr link matrix.

These devices include on-chip decoding and 1 Chip Enable input for memory expansion. They feature either Open Collector or 3-State outputs for optimization of word expansion in bused organizations.

Ordering information can be found on the following page.

The 82S23 and 82S123 devices are also processed to military requirements for operation over the military temperature range. For specifications and ordering information, consult the Signetics Military Data Handbook.

FEATURES

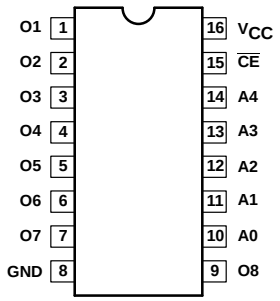
- Address access time: 50ns max
- Power dissipation: 1.3mW/bit typ
- Input loading: –100µA max
- On-chip address decoding
- One Chip Enable input
- Output options:
  - N82S23: Open Collector
  - N82S123: 3-State
- No separate fusing pins
- Unprogrammed outputs are Low level
- Fully TTL compatible

APPLICATIONS

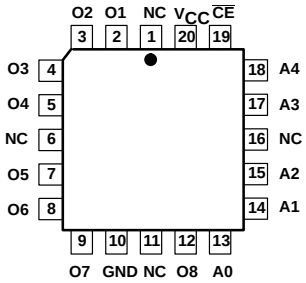
- Prototyping/volume production
- Sequential controllers
- Format conversion
- Hardwired algorithms
- Random logic
- Code conversion

PIN CONFIGURATIONS

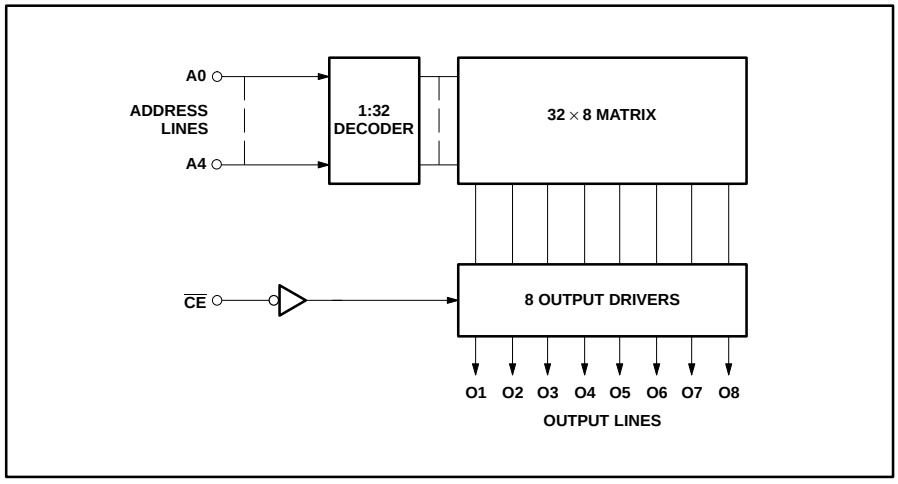
N Package



A Package



BLOCK DIAGRAM



ORDERING INFORMATION

DESCRIPTION	ORDER CODE
16-Pin Plastic Dual-In-Line 300mil-wide	N82S23 N, N82S123 N
20-Pin Plastic Leaded Chip Carrier 350mil-square	N82S23 A, N82S123 A

ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT
V_{CC}	Supply voltage	+7.0	V_{DC}
V_{IN}	Input voltage	+5.5	V_{DC}
V_{OH}	Output voltage High (82S23)	+5.5	V_{DC}
V_O	Output voltage Off-State (82S123)	+5.5	V_{DC}
T_{amb}	Operating temperature range	0 to +75	°C
T_{stg}	Storage temperature range	–65 to +150	°C

DC ELECTRICAL CHARACTERISTICS

$0°C \le T_{amb} \le +75°C$, $4.75V \le V_{CC} \le 5.25V$

SYMBOL	PARAMETER	TEST CONDITIONS[1, 2]	LIMITS			UNIT
			MIN	TYP[3]	MAX	
Input voltage						
V_{IL}	Low	V_{CC} = 4.75V			0.8	V
V_{IH}	High	V_{CC} = 5.25V	2.0			V
V_{IC}	Clamp	I_{IN} = –12mA			–1.2	V
Output voltage						
		$\overline{CE}$ = Low				
V_{OL}	Low	I_{OUT} = 16mA			0.45	V
V_{OH}	High	I_{OUT} = –2.0mA	2.4			V
Input current						
I_{IL}	Low	V_{IN} = 0.45V			–100	µA
I_{IH}	High	V_{IN} = 5.5V			50	µA
Output current						
I_{OLK}	Leakage (82S23)	$\overline{CE}$ = High, V_{OUT} = 5.5V			40	µA
I_{OZ}	Hi-Z state (82S123)	$\overline{CE}$ = High, V_{OUT} = 5.5V			40	µA
		$\overline{CE}$ = High, V_{OUT} = 0.5V			–40	µA
I_{OS}	Short circuit (82S123)[4]	$\overline{CE}$ = Low, V_{OUT} = 0V, High stored	–15		–90	mA
Supply current[5]						
I_{CC}		V_{CC} = 5.25V			96	mA
Capacitance						
		$\overline{CE}$ = High, V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		5		pF
C_{OUT}	Output	V_{OUT} = 2.0V		8		pF

NOTES:
1. Positive current is defined as into the terminal referenced.
2. All voltages with respect to network ground terminal.
3. Typical values are at V_{CC} = 5V, T_{amb} = +25°C.
4. Duration of short circuit should not exceed 1 second.
5. Measured with all inputs grounded and all outputs open.

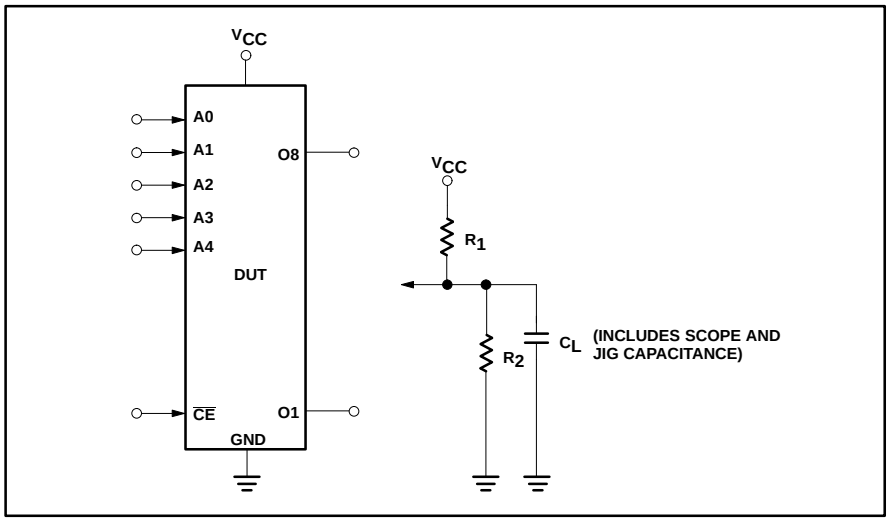
AC ELECTRICAL CHARACTERISTICS

$R_1 = 270\Omega$, $R_2 = 600\Omega$, $C_L = 30F$, $0°C \le T_{amb} \le +75°C$, $4.75V \le V_{CC} \le 5.25V$

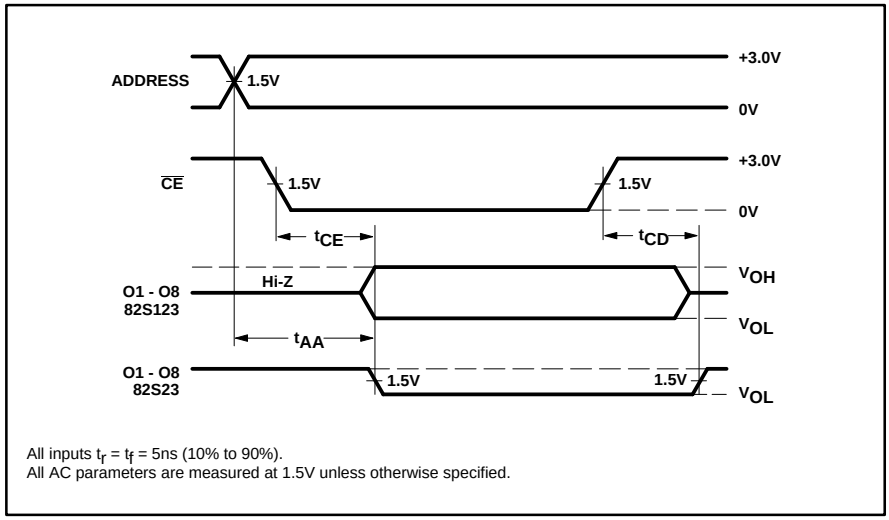
SYMBOL	PARAMETER	TO	FROM	LIMITS			UNIT
				MIN	TYP[1]	MAX	
Access time[2]							
t_{AA}		Output	Address		45	50	ns
t_{CE}		Output	Chip Enable			35	ns
Disable time[3]							
t_{CD}		Output	Chip Disable			35	ns

NOTES:
1. Typical values are $V_{CC} = 5V$, $T_{amb} = +25°C$.
2. Tested at an address cycle time of 1µs.
3. Measured at a delta of 0.5V from Logic Level with $R_1 = 750\Omega$, $R_2 = 750\Omega$ and $C_L = 5pF$.

TEST LOAD CIRCUIT



VOLTAGE WAVEFORMS



All inputs $t_r = t_f = 5ns$ (10% to 90%).
All AC parameters are measured at 1.5V unless otherwise specified.